FCC TEST REPORT

FCC ID : YVV-AEE50510001

Applicant : Shenzhen AEE Technology CO., LTD

Address : AEE Hi-Tech Park, Sun Industrial Area, Xili, Nanshan District,

Shenzhen, P.R.C 518108

Manufacturer: The same as aboveAddress: The same as above

Equipment Under Test (EUT):

Product Name : Action Camcorder

Model No. : S50, S51

Rules : FCC CFR47 Part 15 Section 15.107:2010

FCC CFR47 Part 15 Section 15.109:2010

Date of Test : May 24~June 04, 2013

Date of Issue : June 05, 2013

Test Result : PASS *

Remark:

* The sample described above has been tested to be in compliance with the requirements of ANSI C63.4:2003. The test results have been reviewed and comply with the rules listed above and found to meet their essential requirements.

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company.

The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

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2 Test Summary

Test Items	Test Requirement	Result
Conducted Emission	FCC Part 15.107:2010	PASS
Radiated Emission	FCC Part 15.109:2010	PASS

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4 General Information

4.1 General Description of E.U.T.

Product Name : Action Camcorder

Model No. : \$50, \$51

Model Difference : All the same(included PCB layout and Schematic) except the

model name. The model S50 is testing sample.

Operation Frequency : The highest working frequency of the data transmission model is

80MHz

Type of Modulation : IEEE 802.11b (CCK/QPSK/BPSK,11Mbps max.)

IEEE 802.11g (BPSK/QPSK/16QAM/64QAM,54Mbps max.)

IEEE 802.11n (BPSK/QPSK/16QAM/64QAM,HT20:72Mbps

max.)

Antenna Gain : 0dBi

Oscillator : Crystal 32.768KHz for RTC, 40MHz for RF module

4.2 Details of E.U.T.

Technical Data : (1)DC 3.7V, 1500mAh powered from battery

(2)DC 5V, 2000mA powered from adapter (INPUT:AC 100-240V, 50/60Hz 0.4A)

Adapter : Manufacturer: shenzhen Diasinger Digital co.,ltd

Model:DS-012W0502000LE

4.3 Test Facility

The test facility has a test site registered with the following organizations:

IC – Registration No.: 7760A

Waltek Services(Shenzhen) Co., Ltd. has been registered and fully described in a report filed with the Industry Canada. The acceptance letter from the Industry Canada is maintained in our files.

Registration 7760A, July 12, 2012.

• FCC – Registration No.: 880581

Waltek Services(Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 880581, May 26, 2011.

4.4 Test Location

All the tests were performed at:

Waltek Services(Shenzhen) Co., Ltd. at 1/F, Fukangtai Building, West Baima Rd., Songgang Street, Baoan District, Shenzhen, China

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5 Equipment Used during Test

Conducted Emissions						
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1.	EMI Test Receiver	R&S	ESCI	101155	Aug. 13,2012	Aug. 12,2013
2.	LISN	SCHWARZBECK	NSLK 8128	8128-289	Aug. 13,2012	Aug. 12,2013
3.	Cable	LARGE	RF300	EW02014-3	Aug.14,2012	Aug. 13,2013
3m Se	emi-anechoic Chambe	er for Radiation(TDI	K) (Test Frequei	ncy:32.768kHz	~1000MHz)	
Item	Equipment	Manufacturer	Model No.	Serial No	Last Calibration Date	Calibration Due Date
1	Test Receiver	R&S	ESCI	101296	Aug.09,2012	Aug.08,2013
2	Active Loop Antenna	Beijing Dazhi	ZN30900A	-	Aug. 13,2012	Aug. 12,2013
3	Trilog Broadband Antenna	SCHWARZBECK	VULB9160	9160-3325	Aug.11,2012	Aug.10,2013
4	Amplifier	Compliance pirection systems inc	PAP-0203	22024	Apr.07,2013	Apr.06,2014
5	Cable	HUBER+SUHNE R	CBL2	525178	Sep.15,2012	Sep.14,2013
Associated Equipment						
1	Notebook	IBM	2672-39C	99-8D3W4	-	-

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6 Conducted Emission Data

Test Requirement: FCC Part 15 Section 15.107

Test Method: ANSI C63.4:2003

Test Result: PASS

Frequency Range: 150kHz to 30MHz

Class: Class B

Limit: 66-56 dB_µV between 0.15MHz & 0.5MHz

 $56 \text{ dB}_{\mu}\text{V}$ between 0.5MHz & 5MHz $60 \text{ dB}_{\mu}\text{V}$ between 5MHz & 30MHz

The tighter limit applies at the band edges.

Detector: Peak for pre-scan (9kHz Resolution Bandwidth)

Quasi-Peak & Average if maximised peak within 6dB of

Average Limit

6.1 E.U.T. Operation

Operating Environment:

Temperature: 25.5 °C Humidity: 51 % RH

Atmospheric Pressure: 1012 mbar

EUT Operation:

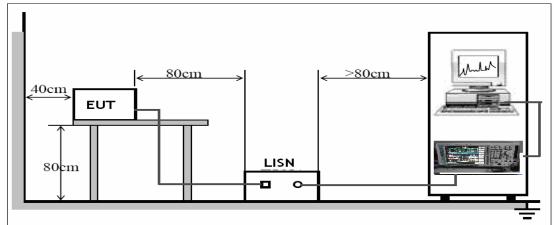
The test was performance on PC connecting mode(data transmitting), the PC mains mains testing. the data is shown as follow.

The EUT was tested according to ANSI C63.4:2003. The frequency spectrum from 150kHz to 30MHz was investigated.

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.

6.2 EUT Setup

The EUT was placed on the test table in shielding room.



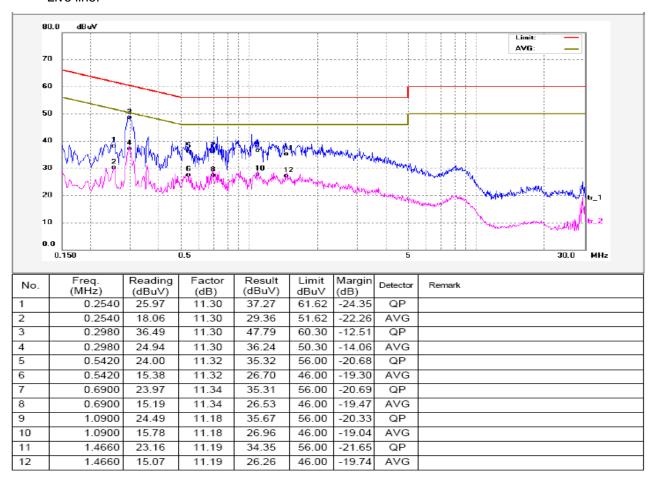
Waltek Services (Shenzhen) Co.,Ltd. http://www.waltek.com.cn

6.3 Conducted Emission Test Result

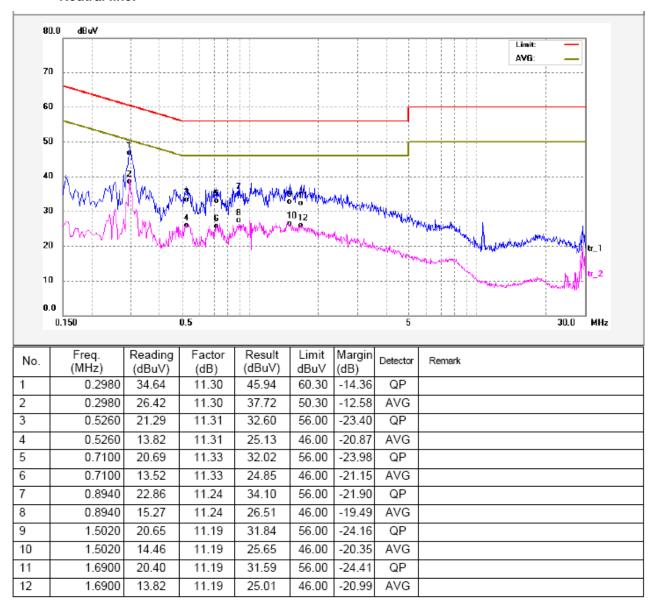
An initial pre-scan was performed on the live and neutral lines.

Test mode: Data Transmitting with PC

Live line:



Neutral line:



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7 Radiation Emission Data

Test Requirement: FCC Part 15 Section 15.109

Test Method: ANSI C63.4:2003

Test Result: PASS

Frequency Range: 32.768kHz to 1GHz

Measurement Distance: 3m

Class: Class B

Limit: 40.0 dB_μV/m between 30MHz & 88MHz for Quasi-Peak

43.5 dB μ V/m between 88MHz & 216MHz for Quasi-Peak 46.0 dB μ V/m between 216MHz & 960MHz for Quasi-Peak

 $54.0 \text{ dB}_{\mu}\text{V/m}$ above 960MHz & 1GHz for Quasi-Peak

54.0 dBuV/m above 1GHz for AV 74.0 dBuV/m above 1GHz for Peak

The tighter limit applies at the band edges.

Detector: Peak for pre-scan (120kHz resolution bandwidth)

Quasi-Peak if maximised peak within 6dB of limit

7.1 E.U.T. Operation

Operating Environment:

Temperature: 25.5 °C Humidity: 51 % RH

Atmospheric Pressure: 1016 mbar

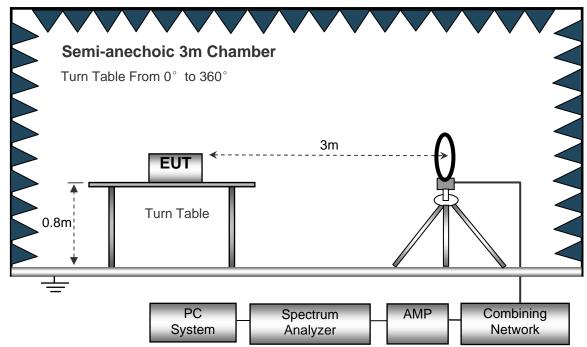
EUT Operation:

The pre-test was performance on Data Transmitting(power input by battery). the data is shown as

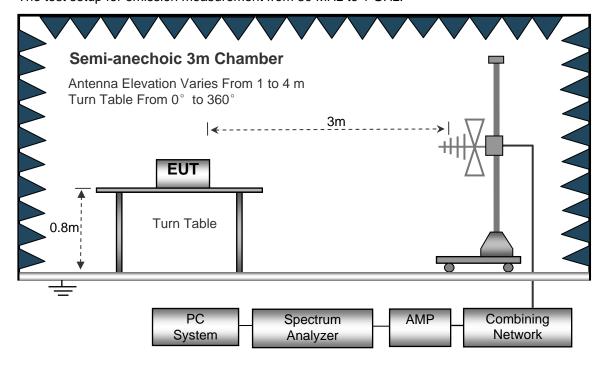
follow.

7.2 EUT Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site. The test setup for emission measurement below 30MHz.



The test setup for emission measurement from 30 MHz to 1 GHz.



7.3 Spectrum Analyzer Setup

According to FCC Part15 B Rules, the system was tested 32.768kHz to 1GHz.

Below 30MHz

Sweep Speed	Auto
IF Bandwidth	10KHz
Video Bandwidth	10KHz
Resolution Bandwidth	10KHz

30MHz ~ 1GHz

Sweep Speed	Auto
IF Bandwidth	120 KHz
Video Bandwidth	100KHz
Quasi-Peak Adapter Bandwidth	120 KHz
Quasi-Peak Adapter Mode	Normal
Resolution Bandwidth	100KHz

7.4 Test Procedure

- 1. The EUT is placed on a turntable, which is 0.8m above ground plane.
- 2. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
- 3. EUT is set 3m away from the receiving antenna, which is moved from 1m to 4m to find out the maximum emissions.
- 4. Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
- 5. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- 6. Repeat above procedures until the measurements for all frequencies are complete.
- 7. The radiation measurements are performed in X(normal uses) axis positioning.

7.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Indicated Reading + Antenna Factor + Cable Factor - Amplifier Gain

The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of $-7dB_{\mu}V$ means the emission is $7dB_{\mu}V$ below the maximum limit for Class B. The equation for margin calculation is as follows:

Margin = Corr. Ampl. - Class B Limit

7.6 Summary of Test Results

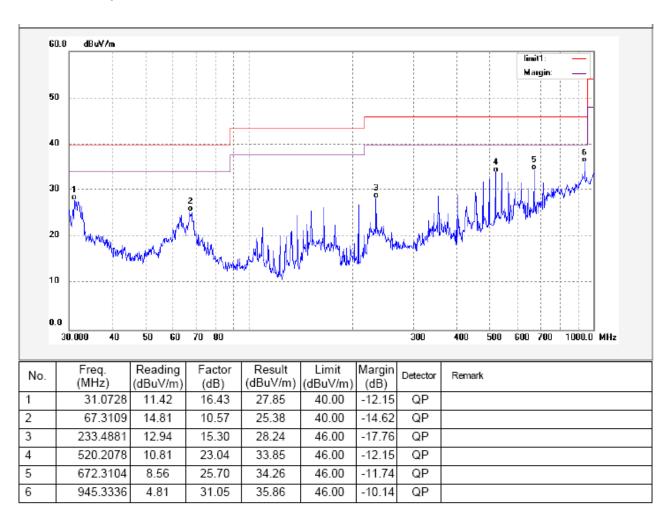
Test Frequency: Below 30MHz

After pretest, we found no higher emission than background level, the data does not been shown in the test report.

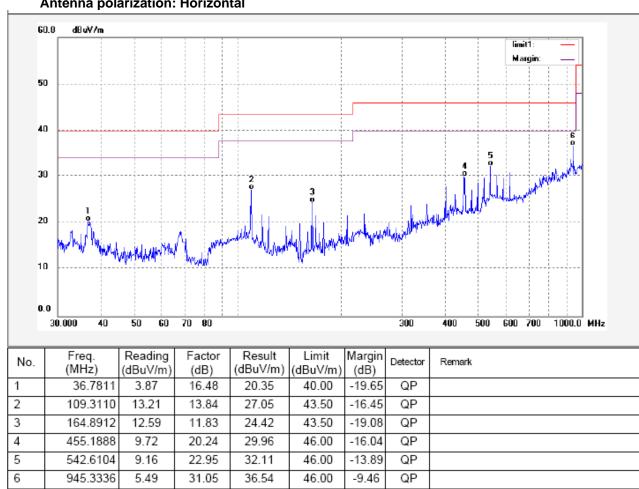
Test Frequency: 30MHz ~ 1000MHz

Test mode: Data Transmitting with PC (power by battery input)

Antenna polarization: Vertical

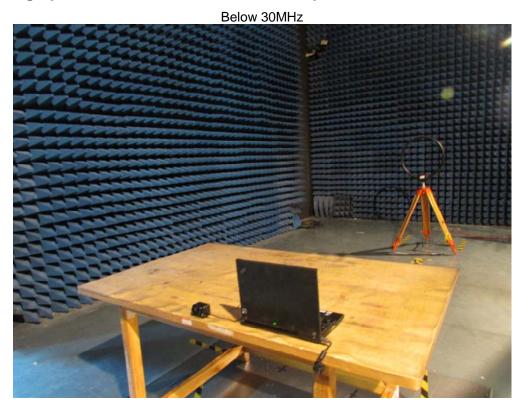


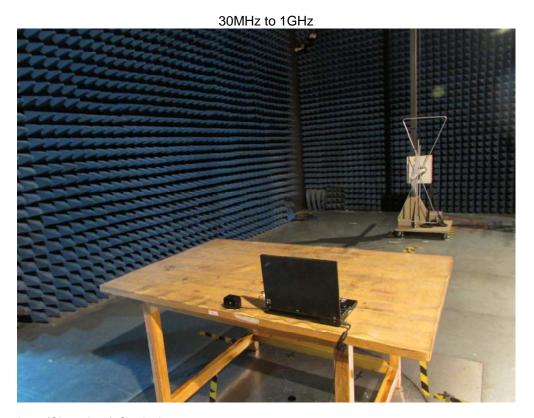
Antenna polarization: Horizontal



8 Photographs – Test Setup

8.1 Photograph – Radiation Emission Test Setup





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8.2 Photograph – Conducted Emission Test Setup



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9 Photographs - Constructional Details

Refer to test report No.: WTS13S0503579E

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